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[^0]
## FDMC7660DC

N-Channel Dual Cool ${ }^{\text {TM }} 33$ PowerTrench ${ }^{\circledR}$ MOSFET
30 V, 40 A, $2.2 \mathrm{~m} \Omega$

## Features

- Dual Cool ${ }^{\text {TM }}$ Top Side Cooling PQFN package
- $\operatorname{Max} \mathrm{r}_{\mathrm{DS}(\text { on })}=2.2 \mathrm{~m} \Omega$ at $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=22 \mathrm{~A}$
- $\operatorname{Max} \mathrm{r}_{\mathrm{DS}(\mathrm{on})}=3.3 \mathrm{~m} \Omega$ at $\mathrm{V}_{\mathrm{GS}}=4.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=18 \mathrm{~A}$
- High performance technology for extremely low $r_{\mathrm{DS}}(\mathrm{on})$
- SyncFET Schottky Body Diode
- RoHS Compliant



## General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench ${ }^{\circledR}$ process. Advancements in both silicon and Dual Cool ${ }^{T M}$ package technologies have been combined to offer the lowest $r_{\text {DS(on) }}$ while maintaining excellent switching performance by extremely low Junction-to-Ambient thermal resistance.

## Applications

- Synchronous Rectifier for DC/DC Converters

Telecom Secondary Side Rectification

- High End Server/Workstation


MOSFET Maximum Ratings $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ unless otherwise noted

| Symbol | Parameter |  | Ratings | Units |
| :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {DS }}$ | Drain to Source Voltage |  | 30 | V |
| $\mathrm{V}_{\mathrm{GS}}$ | Gate to Source Voltage | (Note 4) | $\pm 20$ | V |
| ID | Drain Current -Continuous (Package limited) $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ |  | 40 | A |
|  | -Continuous (Silicon limited) $\quad \mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ |  | 150 |  |
|  | -Continuous $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ | (Note 1a) | 30 |  |
|  | -Pulsed |  | 200 |  |
| $\mathrm{E}_{\text {AS }}$ | Single Pulse Avalanche Energy | (Note 3) | 220 | mJ |
| dv/dt | Peak Diode Recovery dv/dt | (Note 5) | 1.0 | V/ns |
| $\mathrm{P}_{\mathrm{D}}$ | Power Dissipation $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ |  | 78 | W |
|  | Power Dissipation $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ | (Note 1a) | 3.0 |  |
| $\mathrm{T}_{\mathrm{J},}, \mathrm{T}_{\text {STG }}$ | Operating and Storage Junction Temperature Range |  | -55 to +150 | ${ }^{\circ} \mathrm{C}$ |

## Thermal Characteristics

| $\mathrm{R}_{\theta \mathrm{JC}}$ | Thermal Resistance, Junction to Case | (Top Source) | 4.3 |
| :--- | :--- | ---: | :---: |
| $\mathrm{R}_{\theta \mathrm{JC}}$ | Thermal Resistance, Junction to Case | (Bottom Drain) | 1.6 |
| $\mathrm{R}_{\theta \mathrm{JA}}$ | Thermal Resistance, Junction to Ambient | (Note 1a) | 42 |
| $\mathrm{R}_{\theta \mathrm{JA}}$ | Thermal Resistance, Junction to Ambient | (Note 1b) | 105 |
| $\mathrm{R}_{\theta \mathrm{JA}}$ | Thermal Resistance, Junction to Ambient | (Note 1i) | 17 |
| $\mathrm{R}_{\theta \mathrm{JA}}$ | Thermal Resistance, Junction to Ambient | (Note 1j) | 26 |
| $\mathrm{R}_{\theta \mathrm{JA}}$ | Thermal Resistance, Junction to Ambient | (Note 1k) | 12 |

## Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
| :---: | :---: | :---: | :---: | :---: | :---: |
| 7660 | FDMC7660DC | Dual Cool $^{\text {TM }} 33$ | $13^{\prime \prime}$ | 12 mm | 3000 units |

Electrical Characteristics $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Off Characteristics |  |  |  |  |  |  |
| $B V_{\text {DSS }}$ | Drain to Source Breakdown Voltage | $\mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ | 30 |  |  | V |
| $\frac{\Delta \mathrm{BV}_{\mathrm{DSS}}}{\Delta \mathrm{~T}_{\mathrm{J}}}$ | Breakdown Voltage Temperature Coefficient | $\mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$, referenced to $25^{\circ} \mathrm{C}$ |  | 15 |  | $\mathrm{mV} /{ }^{\circ} \mathrm{C}$ |
| IDSS | Zero Gate Voltage Drain Current | $\mathrm{V}_{\mathrm{DS}}=24 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ |  |  | 1 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {GSS }}$ | Gate to Source Leakage Current, Forward | $\mathrm{V}_{\mathrm{GS}}=20 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=0 \mathrm{~V}$ |  |  | 100 | nA |

On Characteristics

| $\mathrm{V}_{\mathrm{GS}}$ (th) | Gate to Source Threshold Voltage | $\mathrm{V}_{\mathrm{GS}}=\mathrm{V}_{\mathrm{DS}}, \mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$ | 1.2 | 2 | 2.5 | V |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\frac{\Delta \mathrm{V}_{\mathrm{GS}(\mathrm{th})}}{\Delta \mathrm{T}_{\mathrm{J}}}$ | Gate to Source Threshold Voltage Temperature Coefficient | $\mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$, referenced to $25^{\circ} \mathrm{C}$ |  | -7 |  | $\mathrm{mV} /{ }^{\circ} \mathrm{C}$ |
| $\mathrm{r}_{\text {DS(on) }}$ | Static Drain to Source On Resistance | $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=22 \mathrm{~A}$ |  | 1.6 | 2.2 | $\mathrm{m} \Omega$ |
|  |  | $\mathrm{V}_{G S}=4.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=18 \mathrm{~A}$ |  | 2.5 | 3.3 |  |
|  |  | $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=22 \mathrm{~A}, \mathrm{~T}_{\mathrm{J}}=125^{\circ} \mathrm{C}$ |  | 2.2 | 3.3 |  |
| $\mathrm{g}_{\mathrm{FS}}$ | Forward Transconductance | $\mathrm{V}_{\mathrm{DS}}=5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=22 \mathrm{~A}$ |  | 147 |  | S |

## Dynamic Characteristics

| $\mathrm{C}_{\text {iss }}$ | Input Capacitance | $\mathrm{V}_{\mathrm{DS}}=15 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ |  | 3885 | 5170 | pF |
| :--- | :--- | :--- | :--- | :---: | :---: | :---: |
| $\mathrm{C}_{\mathrm{oss}}$ | Output Capacitance | $\mathrm{f}=1 \mathrm{MHz}$ |  | 1215 | 1620 | pF |
| $\mathrm{C}_{\text {rss }}$ | Reverse Transfer Capacitance |  |  | 100 | 150 | pF |
| $\mathrm{R}_{\mathrm{g}}$ | Gate Resistance |  |  | 0.7 | 1.5 | $\Omega$ |

## Switching Characteristics

| $\mathrm{t}_{\mathrm{d} \text { (on) }}$ | Turn-On Delay Time | $\begin{aligned} & \mathrm{V}_{\mathrm{DD}}=15 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=22 \mathrm{~A}, \\ & \mathrm{~V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{R}_{\mathrm{GEN}}=6 \Omega \end{aligned}$ | 17 | 31 | ns |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{t}_{\mathrm{r}}$ | Rise Time |  | 6.6 | 13 | ns |
| $\mathrm{t}_{\mathrm{d} \text { (off) }}$ | Turn-Off Delay Time |  | 36 | 58 | ns |
| $\mathrm{t}_{\mathrm{f}}$ | Fall Time |  | 5 | 10 | ns |
| $\mathrm{Q}_{\mathrm{g}}$ | Total Gate Charge | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}$ to 10 V | 54 | 76 | nC |
| $\mathrm{Q}_{\mathrm{g}}$ | Total Gate Charge | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}$ to $4.5 \mathrm{~V} \mathrm{~V}_{\mathrm{DD}}=15 \mathrm{~V}$, | 24 | 34 | nC |
| $\mathrm{Q}_{\mathrm{gs}}$ | Gate to Source Charge | $\mathrm{I}_{\mathrm{D}}=22 \mathrm{~A}$ | 13 |  | nC |
| $\mathrm{Q}_{\mathrm{gd}}$ | Gate to Drain "Miller" Charge |  | 5.5 |  | nC |

## Drain-Source Diode Characteristics

| $V_{\text {SD }}$ | Source-Drain Diode Forward Voltage | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{S}}=22 \mathrm{~A}$ | (Note 2) | 0.8 | 1.2 | V |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{S}}=1.9 \mathrm{~A}$ | (Note 2) | 0.7 | 1.2 |  |
| $\mathrm{t}_{\mathrm{rr}}$ | Reverse Recovery Time | $\mathrm{I}_{\mathrm{F}}=22 \mathrm{~A}, \mathrm{di} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{s}$ |  | 43 | 69 | ns |
| $\mathrm{Q}_{\text {rr }}$ | Reverse Recovery Charge |  |  | 24 | 38 | nC |

## Thermal Characteristics

| $\mathrm{R}_{\text {өJC }}$ | Thermal Resistance，Junction to Case | （Top Source） | 4.3 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| :---: | :---: | :---: | :---: | :---: |
| $\mathrm{R}_{\text {өJC }}$ | Thermal Resistance，Junction to Case | （Bottom Drain） | 1.6 |  |
| $\mathrm{R}_{\text {өJA }}$ | Thermal Resistance，Junction to Ambient | （Note 1a） | 42 |  |
| $\mathrm{R}_{\text {日JA }}$ | Thermal Resistance，Junction to Ambient | （Note 1b） | 105 |  |
| $\mathrm{R}_{\text {日JA }}$ | Thermal Resistance，Junction to Ambient | （Note 1c） | 29 |  |
| $\mathrm{R}_{\text {日JA }}$ | Thermal Resistance，Junction to Ambient | （Note 1d） | 40 |  |
| $\mathrm{R}_{\text {日JA }}$ | Thermal Resistance，Junction to Ambient | （Note 1e） | 19 |  |
| $\mathrm{R}_{\text {日JA }}$ | Thermal Resistance，Junction to Ambient | （Note 1f） | 23 |  |
| $\mathrm{R}_{\text {日JA }}$ | Thermal Resistance，Junction to Ambient | （Note 19） | 30 |  |
| $\mathrm{R}_{\text {日JA }}$ | Thermal Resistance，Junction to Ambient | （Note 1h） | 79 |  |
| $\mathrm{R}_{\text {日JA }}$ | Thermal Resistance，Junction to Ambient | （Note 1i） | 17 |  |
| $\mathrm{R}_{\text {日JA }}$ | Thermal Resistance，Junction to Ambient | （Note 1j） | 26 |  |
| $\mathrm{R}_{\text {日JA }}$ | Thermal Resistance，Junction to Ambient | （Note 1k） | 12 |  |
| $\mathrm{R}_{\text {日JA }}$ | Thermal Resistance，Junction to Ambient | （Note 1） | 16 |  |

NOTES
1．$R_{\theta J A}$ is determined with the device mounted on a FR－4 board using a specified pad of 2 oz copper as shown below．$R_{\theta J C}$ is guaranteed by design while $R_{\theta C A}$ is determined by the user＇s board design．
ㅇo000
a． $42^{\circ} \mathrm{C} / \mathrm{W}$ when mounted on a 1 in $^{2}$ pad of 2 oz copper

b． $105^{\circ} \mathrm{C} / \mathrm{W}$ when mounted on a minimum pad of 2 oz copper
c．Still air， $20.9 \times 10.4 \times 12.7 \mathrm{~mm}$ Aluminum Heat Sink， $1 \mathrm{in}^{2}$ pad of 2 oz copper
d．Still air， $20.9 \times 10.4 \times 12.7 \mathrm{~mm}$ Aluminum Heat Sink，minimum pad of 2 oz copper
e．Still air， $45.2 \times 41.4 \times 11.7 \mathrm{~mm}$ Aavid Thermalloy Part \＃10－L41B－11 Heat Sink， $1 \mathrm{in}^{2}$ pad of 2 oz copper
f．Still air， $45.2 \times 41.4 \times 11.7 \mathrm{~mm}$ Aavid Thermalloy Part \＃10－L41B－11 Heat Sink，minimum pad of 2 oz copper
g．200FPM Airflow，No Heat Sink， 1 in $^{2}$ pad of 2 oz copper
h．200FPM Airflow，No Heat Sink，minimum pad of 2 oz copper
i．200FPM Airflow， $20.9 \times 10.4 \times 12.7 \mathrm{~mm}$ Aluminum Heat Sink， $1 \mathrm{in}^{2}$ pad of 2 oz copper
j．200FPM Airflow， $20.9 \times 10.4 \times 12.7 \mathrm{~mm}$ Aluminum Heat Sink，minimum pad of 2 oz copper
k．200FPM Airflow， $45.2 \times 41.4 \times 11.7 \mathrm{~mm}$ Aavid Thermalloy Part \＃10－L41B－11 Heat Sink， $1 \mathrm{in}^{2}$ pad of 2 oz copper
I．200FPM Airflow， $45.2 \times 41.4 \times 11.7 \mathrm{~mm}$ Aavid Thermalloy Part \＃10－L41B－11 Heat Sink，minimum pad of 2 oz copper

2．Pulse Test：Pulse Width $<300 \mu \mathrm{~s}$ ，Duty cycle $<2.0 \%$ ．
3． $\mathrm{E}_{\mathrm{AS}}$ of 220 mJ is based on starting $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C} ; \mathrm{N}-\mathrm{ch}: \mathrm{L}=1 \mathrm{mH}, \mathrm{I}_{\mathrm{AS}}=21 \mathrm{~A}, \mathrm{~V}_{\mathrm{DD}}=27 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=10 \mathrm{~V} .100 \%$ test at $\mathrm{L}=0.3 \mathrm{mH}, \mathrm{I}_{\mathrm{AS}}=33.5 \mathrm{~A}$ ．
4．As an N －ch device，the negative Vg s rating is for low duty cycle pulse ocurrence only．No continuous rating is implied
5． $\mathrm{I}_{\mathrm{SD}} \leq 22 \mathrm{~A}, \mathrm{di} / \mathrm{dt} \leq 100 \mathrm{~A} / \mu \mathrm{s}, \mathrm{V}_{\mathrm{DD}} \leq \mathrm{BV}_{\mathrm{DSS}}$ ，Starting $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ ．

Typical Characteristics $\mathrm{T}_{J}=25^{\circ} \mathrm{C}$ unless otherwise noted


Figure 1. On Region Characteristics


Figure 3. Normalized On Resistance vs Junction Temperature


Figure 5. Transfer Characteristics


Figure2. Normalized On-Resistance vs Drain Current and Gate Voltage


Figure 4. On-Resistance vs Gate to Source Voltage


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $\mathrm{T}_{J}=25^{\circ} \mathrm{C}$ unless otherwise noted


Figure 7. Gate Charge Characteristics


Figure 9. Unclamped Inductive Switching Capability


Figure 11. Forward Bias Safe Operating Area


Figure8. Capacitance vs Drain to Source Voltage


Figure 10. Maximum Continuous Drain Current vs Case Temperature


Figure 12. Single Pulse Maximum Power Dissipation

## Typical Characteristics $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ unless otherwise noted



Figure 13. Junction-to-Ambient Transient Thermal Response Curve


## LAND PATTERN RECOMMENDATION

NOTES: UNLESS OTHERWISE SPECIFIED
A) PACKAGE STANDARD REFERENCE: JEDEC MO-240, ISSUE A, VAR. BA, DATED OCTOBER 2002.
B) ALL DIMENSIONS ARE IN MILLIMETERS.
C) DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
D) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-2009.
E) DRAWING FILE NAME: PQFN08CREV3



#### Abstract

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